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				Application Number	1/558,434
				Filing Date	November 29, 2005
				First Named Inventor	HA, Sam-Chul
				Art Unit	TBA
				Examiner Name	WYLLIE, CHRISTOPHER T
Sheet	1	of	3	Attorney Docket Number	7950.036.00

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Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Signature	/Albert Chou/		Date Considered 06/18/2009

DC:50599813.1

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